

RF LDMOS Wideband Integrated Power Amplifiers

The MMRF2005N wideband integrated circuit is designed with on-chip matching that makes it usable from 728 to 960 MHz. This multi-stage structure is rated for 24 to 32 V operation and is ideal for applications including radio communications, data links and UHF radar.

Driver Application — 900 MHz

- Typical Single-Carrier W-CDMA Performance: $V_{DD} = 28$ Vdc, $I_{DQ1} = 106$ mA, $I_{DQ2} = 285$ mA, $P_{out} = 3.2$ W Avg., IQ Magnitude Clipping, Channel Bandwidth = 3.84 MHz, Input Signal PAR = 7.5 dB @ 0.01% Probability on CCDF.

Frequency (1)	G_{ps} (dB)	PAE (%)	ACPR (dBc)
920 MHz	36.6	16.1	-48.0
940 MHz	36.8	16.7	-48.7
960 MHz	36.6	17.3	-48.6

- Capable of Handling 10:1 VSWR, @ 32 Vdc, 940 MHz, 48 W CW Output Power (3 dB Input Overdrive from Rated P_{out})

Driver Application — 700 MHz

- Typical Single-Carrier W-CDMA Performance: $V_{DD} = 28$ Vdc, $I_{DQ1} = 106$ mA, $I_{DQ2} = 285$ mA, $P_{out} = 3.2$ W Avg., IQ Magnitude Clipping, Channel Bandwidth = 3.84 MHz, Input Signal PAR = 7.5 dB @ 0.01% Probability on CCDF.

Frequency	G_{ps} (dB)	PAE (%)	ACPR (dBc)
728 MHz	36.4	16.1	-47.7
748 MHz	36.4	16.1	-47.8
768 MHz	36.4	16.0	-47.9

Features

- Characterized with series equivalent large-signal impedance parameters and common source S-parameters
- On-chip matching (50 ohm input, DC blocked, > 5 ohm output)
- Integrated quiescent current temperature compensation with enable/disable function (2)
- Integrated ESD protection

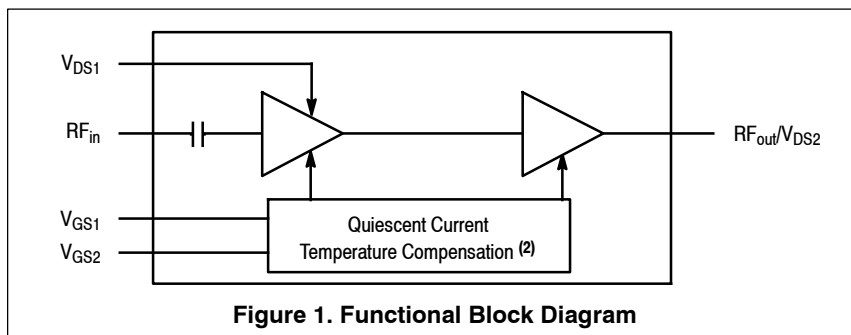
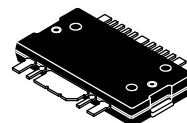


Figure 1. Functional Block Diagram

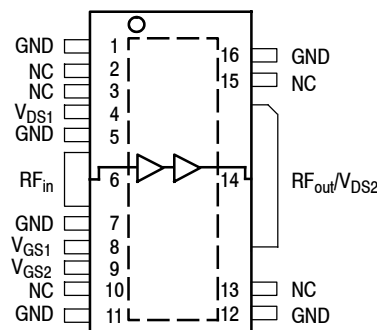
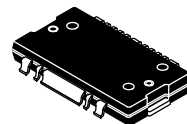
MMRF2005N MMRF2005GN

728–960 MHz, 3.2 W AVG., 28 V
RF LDMOS WIDEBAND
INTEGRATED POWER AMPLIFIERS

TO-270WB-16
PLASTIC
MMRF2005N



TO-270WBG-16
PLASTIC
MMRF2005GN



(Top View)

Note: Exposed backside of the package is the source terminal for the transistors.

Figure 2. Pin Connections

1. 900 MHz Driver Frequency Band table data collected in the 900 MHz application circuit. See Fig. 9.

2. Refer to [AN1977](#), Quiescent Current Thermal Tracking Circuit in the RF Integrated Circuit Family, and to [AN1987](#), Quiescent Current Control for the RF Integrated Circuit Device Family. Go to <http://www.freescale.com/rf> and search for AN1977 or AN1987.

Table 1. Maximum Ratings

Rating	Symbol	Value	Unit
Drain–Source Voltage	V_{DS}	–0.5, +65	Vdc
Gate–Source Voltage	V_{GS}	–6.0, +10	Vdc
Operating Voltage	V_{DD}	32, +0	Vdc
Storage Temperature Range	T_{stg}	–65 to +150	°C
Case Operating Temperature Range	T_C	–40 to +150	°C
Operating Junction Temperature Range ^(1,2)	T_J	–40 to +225	°C
Input Power	P_{in}	20	dBm

Table 2. Thermal Characteristics

Characteristic	Symbol	Value ^(2,3)	Unit
Thermal Resistance, Junction to Case	$R_{\theta JC}$		°C/W
Case Temperature 80°C, 3.2 W CW, 940 MHz			
Stage 1, 28 Vdc, I_{DQ1} = 106 mA		5.5	
Stage 2, 28 Vdc, I_{DQ2} = 285 mA		1.6	
Case Temperature 80°C, 30 W CW, 940 MHz			
Stage 1, 28 Vdc, I_{DQ1} = 40 mA		5.8	
Stage 2, 28 Vdc, I_{DQ2} = 340 mA		1.2	

Table 3. ESD Protection Characteristics

Test Methodology	Class
Human Body Model (per JESD22-A114)	1B, passes 500 V
Machine Model (per EIA/JESD22-A115)	A, passes 100 V
Charge Device Model (per JESD22-C101)	II, passes 200 V

Table 4. Moisture Sensitivity Level

Test Methodology	Rating	Package Peak Temperature	Unit
Per JESD22-A113, IPC/JEDEC J-STD-020	3	260	°C

Table 5. Electrical Characteristics (T_A = 25°C unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
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Stage 1 — Off Characteristics

Zero Gate Voltage Drain Leakage Current (V_{DS} = 65 Vdc, V_{GS} = 0 Vdc)	I_{DSS}	—	—	10	μ Adc
Zero Gate Voltage Drain Leakage Current (V_{DS} = 28 Vdc, V_{GS} = 0 Vdc)	I_{DSS}	—	—	1	μ Adc
Gate–Source Leakage Current (V_{GS} = 1.5 Vdc, V_{DS} = 0 Vdc)	I_{GSS}	—	—	1	μ Adc

Stage 1 — On Characteristics

Gate Threshold Voltage (V_{DS} = 10 Vdc, I_D = 14 μ Adc)	$V_{GS(th)}$	1.2	2	2.7	Vdc
Gate Quiescent Voltage (V_{DS} = 28 Vdc, I_{DQ1} = 106 mA)	$V_{GS(Q)}$	—	2.8	—	Vdc
Fixture Gate Quiescent Voltage ⁽⁴⁾ (V_{DD} = 28 Vdc, I_{DQ1} = 106 mA, Measured in Functional Test)	$V_{GG(Q)}$	6.9	9.4	11.9	Vdc

1. Continuous use at maximum temperature will affect MTTF.
2. MTTF calculator available at <http://www.freescale.com/rf/calculators>.
3. Refer to [AN1955](#), *Thermal Measurement Methodology of RF Power Amplifiers*. Go to <http://www.freescale.com/rf> and search for AN1955.
4. $V_{GG} = 3.3 \times V_{GS(Q)}$. Parameter measured on Freescale test fixture, due to resistor divider network on the board. Refer to test circuit schematic.

(continued)

Table 5. Electrical Characteristics ($T_A = 25^\circ\text{C}$ unless otherwise noted) (continued)

Characteristic	Symbol	Min	Typ	Max	Unit
Stage 2 — Off Characteristics					
Zero Gate Voltage Drain Leakage Current ($V_{DS} = 65\text{ Vdc}$, $V_{GS} = 0\text{ Vdc}$)	I_{DSS}	—	—	10	μAdc
Zero Gate Voltage Drain Leakage Current ($V_{DS} = 28\text{ Vdc}$, $V_{GS} = 0\text{ Vdc}$)	I_{DSS}	—	—	1	μAdc
Gate-Source Leakage Current ($V_{GS} = 1.5\text{ Vdc}$, $V_{DS} = 0\text{ Vdc}$)	I_{GSS}	—	—	1	μAdc

Stage 2 — On Characteristics

Gate Threshold Voltage ($V_{DS} = 10\text{ Vdc}$, $I_D = 74\text{ }\mu\text{Adc}$)	$V_{GS(th)}$	1.2	2	2.7	Vdc
Gate Quiescent Voltage ($V_{DS} = 28\text{ Vdc}$, $I_{DQ2} = 285\text{ mA}$)	$V_{GS(Q)}$	—	2.6	—	Vdc
Fixture Gate Quiescent Voltage ⁽¹⁾ ($V_{DD} = 28\text{ Vdc}$, $I_{DQ2} = 285\text{ mA}$, Measured in Functional Test)	$V_{GG(Q)}$	4.2	5.9	7.6	Vdc
Drain-Source On-Voltage ($V_{GS} = 10\text{ Vdc}$, $I_D = 740\text{ mA}$)	$V_{DS(on)}$	0.1	0.3	0.8	Vdc

Functional Tests ^(2,3) (In Freescale Test Fixture, 50 ohm system) $V_{DD} = 28\text{ Vdc}$, $I_{DQ1} = 106\text{ mA}$, $I_{DQ2} = 285\text{ mA}$, $P_{out} = 3.2\text{ W Avg.}$, $f = 940\text{ MHz}$, Single-Carrier W-CDMA, 3.84 MHz Channel Bandwidth Carrier, IQ Magnitude Clipping, Input Signal PAR = 7.5 dB @ 0.01% Probability on CCDF. ACPR measured in 3.84 MHz Channel Bandwidth @ $\pm 5\text{ MHz}$ Offset.

Power Gain	G_{ps}	33	35.9	38	dB
Power Added Efficiency	PAE	14	16.5	—	%
Adjacent Channel Power Ratio	ACPR	—	-49.5	-46	dBc
Input Return Loss	IRL	—	-18.7	-9	dB

Typical Performance — 900 MHz (In Freescale 900 MHz Application Test Fixture, 50 ohm system) $V_{DD} = 28\text{ Vdc}$, $I_{DQ1} = 106\text{ mA}$, $I_{DQ2} = 285\text{ mA}$, 920–960 MHz Bandwidth

$V_{DD} = 28\text{ Vdc}$, $I_{DQ1} = 40\text{ mA}$, $I_{DQ2} = 340\text{ mA}$ P_{out} @ 1 dB Compression Point, CW	P_{1dB}	—	31	—	W
IMD Symmetry @ 25 W PEP, P_{out} where IMD Third Order Intermodulation $\cong 30\text{ dBc}$ (Delta IMD Third Order Intermodulation between Upper and Lower Sidebands > 2 dB)	IMD_{sym}	—	45	—	MHz
VBW Resonance Point (IMD Third Order Intermodulation Inflection Point)	VBW_{res}	—	80	—	MHz
Quiescent Current Accuracy over Temperature ⁽⁴⁾ with 3 k Ω Gate Feed Resistors (-30 to 85°C)	ΔI_{QT}	—	0.02	—	%
Gain Flatness in 40 MHz Bandwidth @ $P_{out} = 3.2\text{ W Avg.}$	G_F	—	0.2	—	dB
Gain Variation over Temperature (-30°C to $+85^\circ\text{C}$)	ΔG	—	0.036	—	dB/ $^\circ\text{C}$
Output Power Variation over Temperature (-30°C to $+85^\circ\text{C}$)	ΔP_{1dB}	—	0.01	—	dBm/ $^\circ\text{C}$

Table 6. Ordering Information

Device	Tape and Reel Information	Package
MMRF2005NR1	R1 Suffix = 500 Units, 44 mm Tape Width, 13-inch Reel	TO-270WB-16
MMRF2005GNR1		TO-270WBG-16

- $V_{GG} = 2.25 \times V_{GS(Q)}$. Parameter measured on Freescale test fixture, due to resistor divider network on the board. Refer to test circuit schematic.
- Part internally matched both on input and output.
- Measurements made with device in straight lead configuration before any lead forming operation is applied. Lead forming is used for gull wing (GN) parts.
- Refer to [AN1977](#), Quiescent Current Thermal Tracking Circuit in the RF Integrated Circuit Family, and to [AN1987](#), Quiescent Current Control for the RF Integrated Circuit Device Family. Go to <http://www.freescale.com/rf> and search for AN1977 or AN1987.

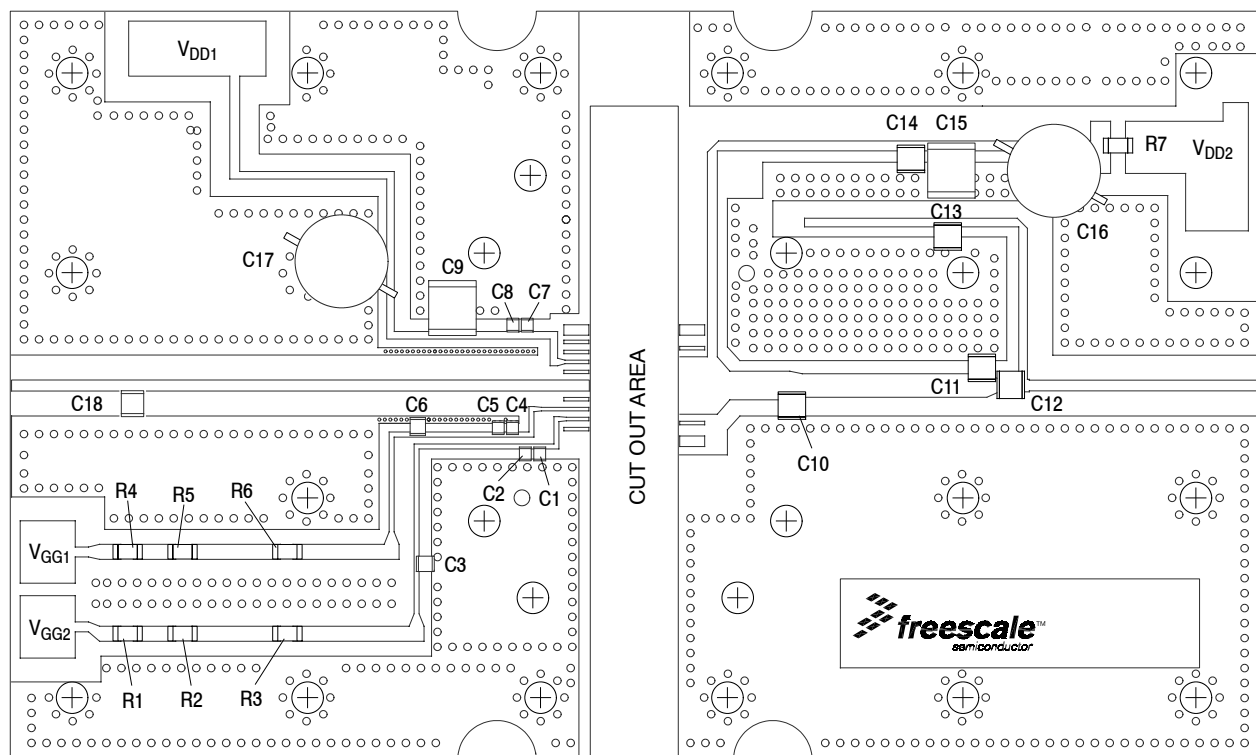
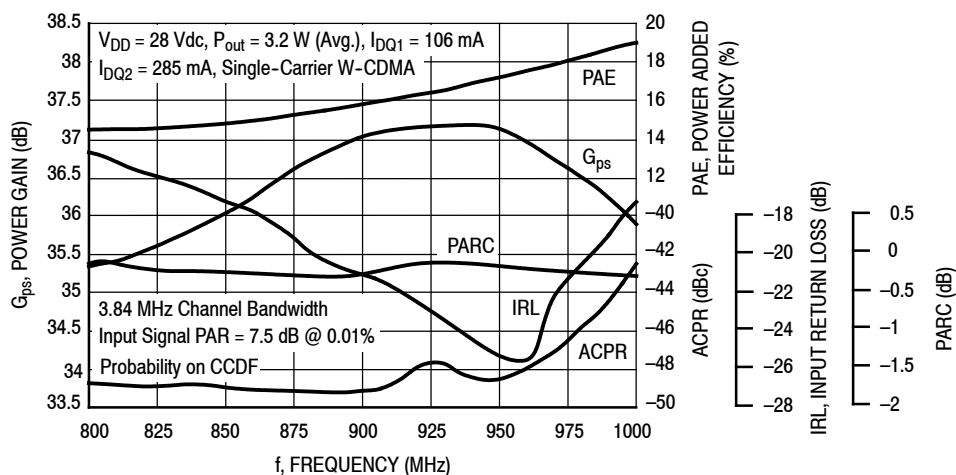


Figure 3. MMRF2005N Test Circuit Component Layout — 900 MHz

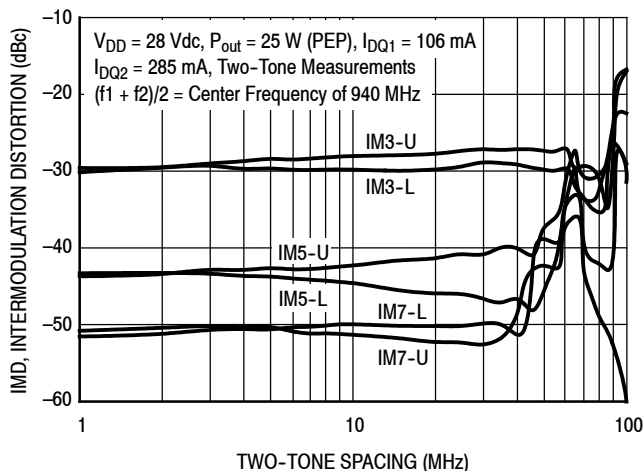
Table 7. MMRF2005N Test Circuit Component Designations and Values — 900 MHz

Part	Description	Part Number	Manufacturer
C1, C4, C7	47 pF Chip Capacitors	ATC600F470JT250XT	ATC
C2, C5, C8	10 nF, 50 V Chip Capacitors	C0603C103J5RAC-TU	Kemet
C3, C6	1 μ F, 50 V Chip Capacitors	GRM21BR71H105KA12L	Murata
C9, C15	10 μ F, 50 V Chip Capacitors	GRM55DR61H106KA88L	Murata
C10	16 pF Chip Capacitor	ATC100B160JT500XT	ATC
C11	6.2 pF Chip Capacitor	ATC100B6R2BT500XT	ATC
C12	7.5 pF Chip Capacitor	ATC100B7R5CT500XT	ATC
C13, C14	47 pF Chip Capacitors	ATC100B470JT500XT	ATC
C16, C17	100 μ F, 50 V Electrolytic Capacitors	MCGPR35V337M10X16-RH	Multicomp
C18	0.5 pF Chip Capacitor	ATC100B0R5BT500XT	ATC
R1, R2, R3, R4, R5, R6	1000 Ω , 1/4 W Chip Resistors	CRCW12061K00FKEA	Vishay
R7	0 Ω , 3A Chip Resistor	CRCW12060000Z0EA	Vishay
PCB	0.020", $\epsilon_r = 3.5$	RF-35	Taconic

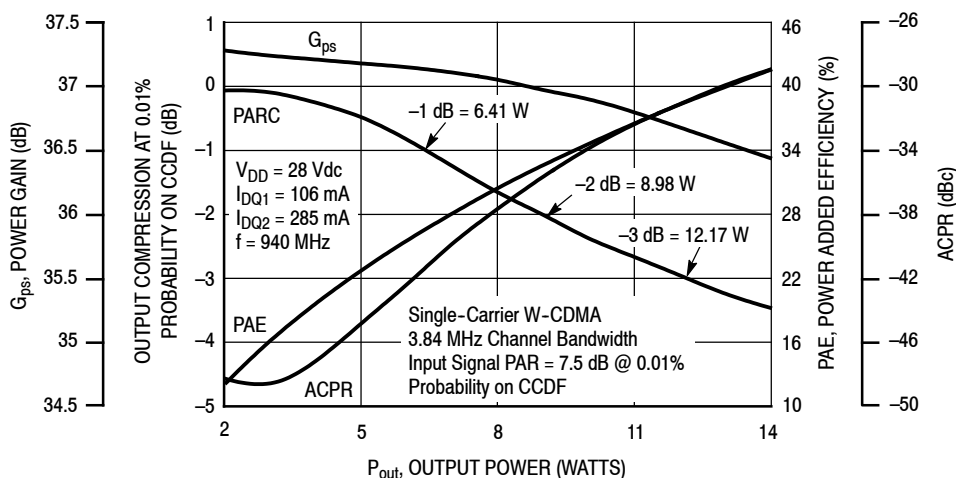
TYPICAL CHARACTERISTICS — 900 MHz



**Figure 4. Output Peak-to-Average Ratio Compression (PARC)
Broadband Performance @ $P_{out} = 3.2$ Watts Avg.**



**Figure 5. Intermodulation Distortion Products
versus Two-Tone Spacing**



**Figure 6. Output Peak-to-Average Ratio
Compression (PARC) versus Output Power**

TYPICAL CHARACTERISTICS — 900 MHz

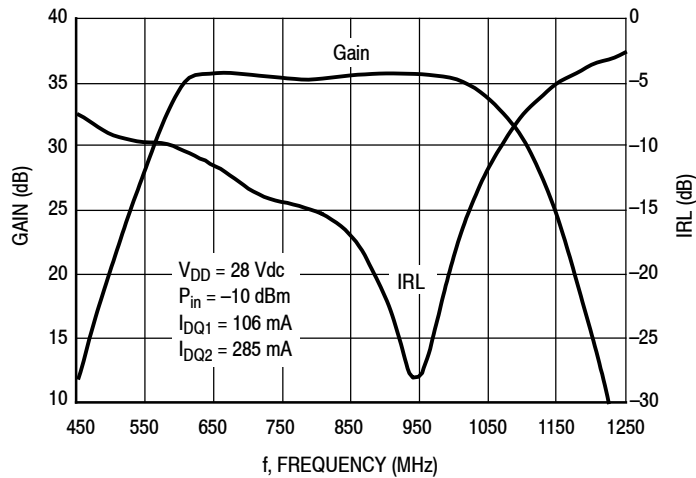


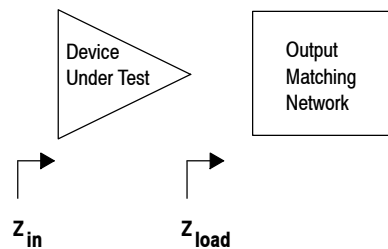
Figure 7. Broadband Frequency Response

Table 8. Series Equivalent Input and Load Impedance — 900 MHz

f MHz	Z_{in} Ω	Z_{load} Ω
820	$37.95 + j2.31$	$4.70 + j0.98$
840	$39.95 + j2.72$	$4.29 + j1.23$
860	$42.70 + j1.02$	$3.93 + j1.67$
880	$44.40 - j1.38$	$3.63 + j2.15$
900	$46.25 - j4.92$	$3.41 + j2.61$
920	$45.70 - j8.41$	$3.14 + j3.05$
940	$45.46 - j11.47$	$2.94 + j3.48$
960	$45.07 - j15.19$	$2.85 + j3.90$
980	$43.49 - j18.03$	$2.69 + j4.32$

Z_{in} = Device input impedance as measured from gate to ground.

Z_{load} = Test circuit impedance as measured from drain to ground.



LOAD PULL CHARACTERISTICS — 900 MHz

Table 9. Load Pull Performance $V_{DD} = 28 \text{ Vdc}$,
 $I_{DQ1} = 106 \text{ mA}$, $I_{DQ2} = 285 \text{ mA}$, Pulsed CW, $10 \mu\text{sec}(\text{on})$, 10% Duty Cycle

f (MHz)	P1dB		P3dB	
	Watts	dBm	Watts	dBm
920	43	46.3	51	47.1
940	42	46.3	50	47
960	42	46.3	50	47

NOTE: Load Pull Test Fixture Tuned for Peak P1dB Output Power @ 28 V

Test Impedances per Compression Level

f (MHz)		Z_{source} Ω	Z_{load} Ω
920	P1dB	$55.82 + j15.71$	$4.54 + j1.15$
940	P1dB	$52.56 + j20.20$	$4.38 + j1.21$
960	P1dB	$49.18 + j25.00$	$5.04 + j1.15$

900 MHz APPLICATION CIRCUIT

Table 10. 900 MHz Performance (In Freescale Application Circuit, 50 ohm system) $V_{DD} = 28$ Vdc, $I_{DQ1} = 106$ mA, $I_{DQ2} = 285$ mA, $P_{out} = 3.2$ W Avg., Channel Bandwidth = 3.84 MHz, Input Signal PAR = 7.5 dB @ 0.01% Probability on CCDF

Frequency (MHz)	G_{ps} (dB)	PAE (%)	ACPR (dBc)
920	36.6	16.1	-48.0
940	36.8	16.7	-48.7
960	36.6	17.3	-48.6

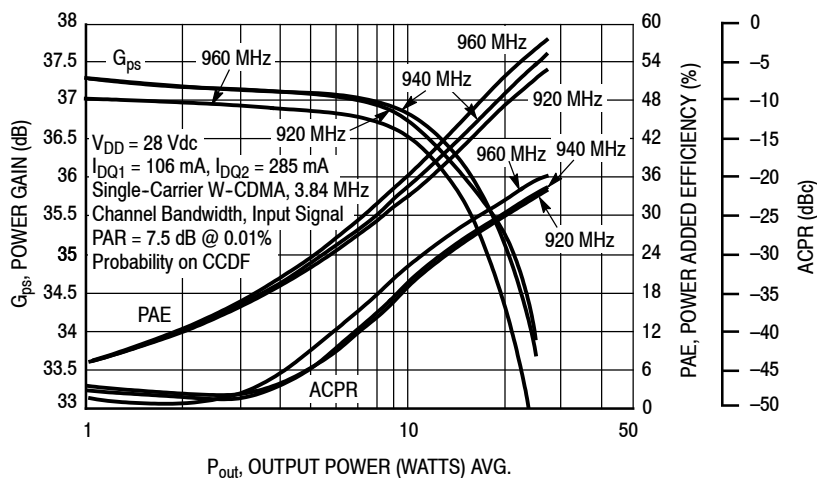


Figure 8. Single-Carrier W-CDMA Power Gain, Power Added Efficiency and ACPR versus Output Power

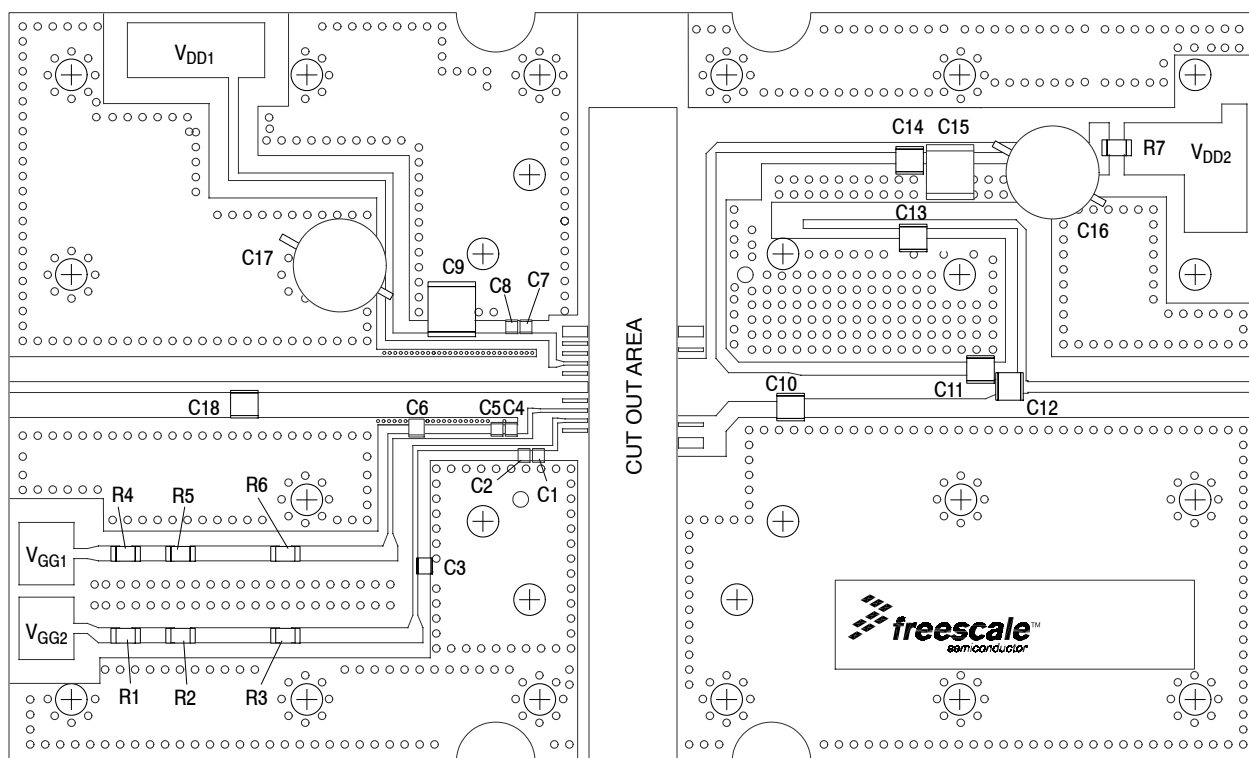


Figure 9. MMRF2005N Test Circuit Component Layout — 700 MHz

Table 11. MMRF2005N Test Circuit Component Designations and Values — 700 MHz

Part	Description	Part Number	Manufacturer
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C2, C5, C8	10 nF, 50 V Chip Capacitors	C0603C103J5RAC	Kemet
C3, C6	1 μ F, 50 V Chip Capacitors	GRM21BR71H105KA12L	Murata
C9, C15	10 μ F, 50 V Chip Capacitors	GRM55DR61H106KA88L	Murata
C10	13 pF Chip Capacitor	ATC100B130JT500XT	ATC
C11	7.5 pF Chip Capacitor	ATC100B7R5CT500XT	ATC
C12	6.8 pF Chip Capacitor	ATC100B6R8CT500XT	ATC
C13, C14	47 pF Chip Capacitors	ATC100B470JT500XT	ATC
C16, C17	100 μ F, 50 V Electrolytic Capacitors	MCGPR35V337M10X16-RH	Multicomp
C18	1.8 pF Chip Capacitor	ATC100B1R8BT500XT	ATC
R1, R2, R3, R4, R5, R6	1000 Ω , 1/4 W Chip Resistors	CRCW12061K00FKEA	Vishay
R7	0 Ω , 3A Chip Resistor	CRCW12060000Z0EA	Vishay
PCB	0.020", $\epsilon_r = 3.5$	RF-35	Taconic

TYPICAL CHARACTERISTICS — 700 MHz

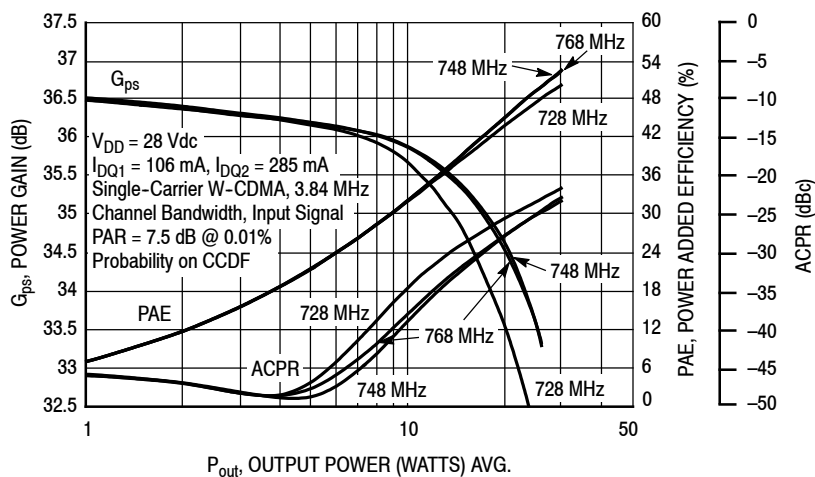


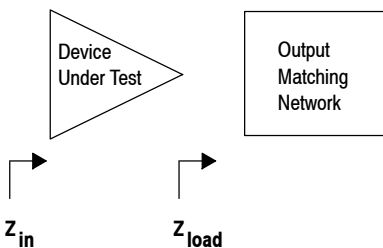
Figure 10. Single-Carrier W-CDMA Power Gain, Power Added Efficiency and ACPR versus Output Power — 700 MHz

Table 12. Series Equivalent Input and Load Impedance — 700 MHz

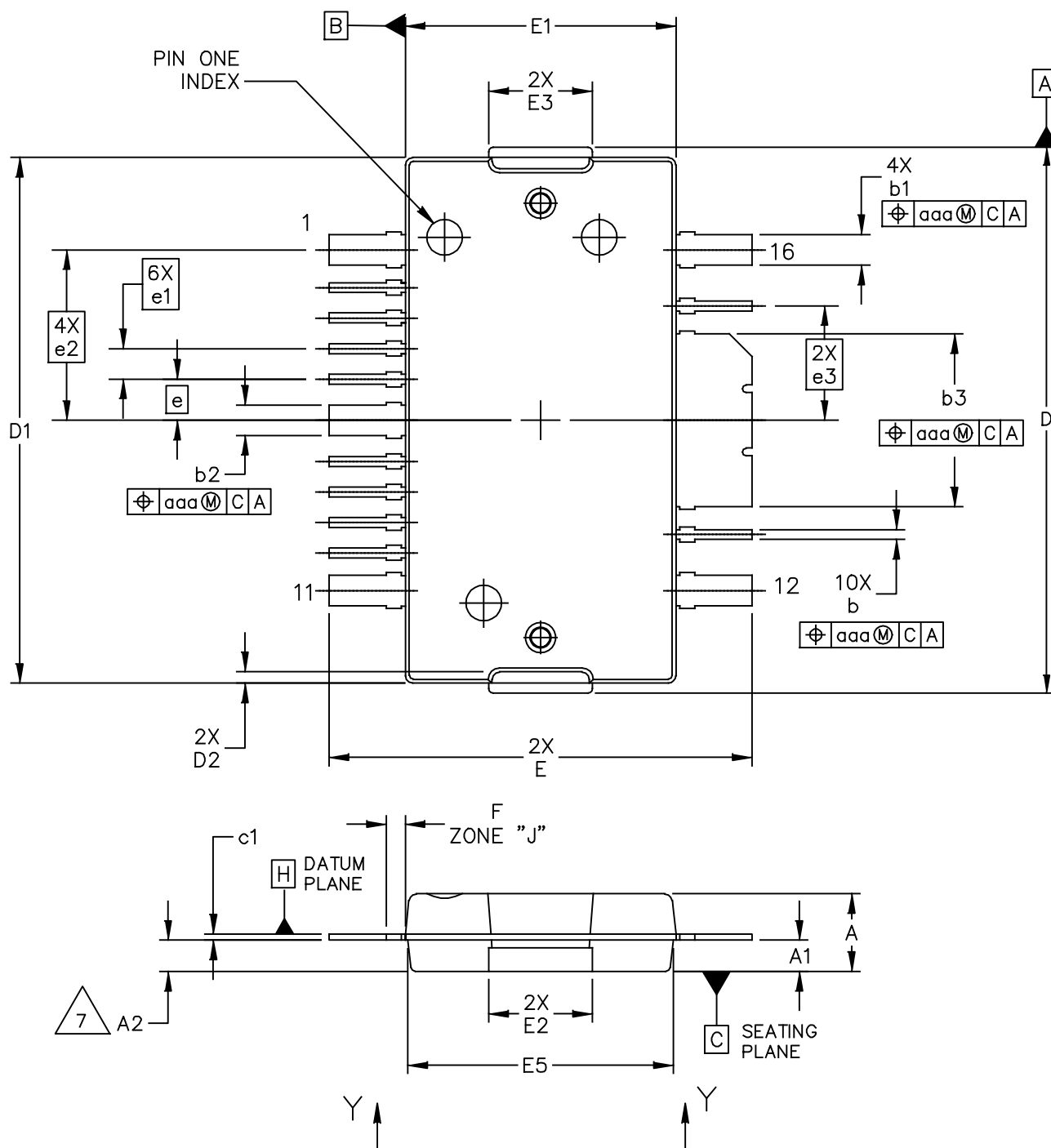
f MHz	Z_{in} Ω	Z_{load} Ω
710	$25.21 - j1.21$	$8.57 + j2.52$
720	$33.76 + j5.36$	$8.52 + j2.46$
730	$38.78 + j1.40$	$8.44 + j2.34$
740	$40.14 - j0.76$	$8.36 + j2.16$
750	$35.46 - j1.15$	$8.30 + j2.00$
760	$34.65 - j0.53$	$8.32 + j1.90$
770	$34.75 - j0.43$	$8.31 + j1.86$
780	$36.20 + j0.81$	$8.27 + j1.98$
790	$36.18 + j1.33$	$8.23 + j2.12$

Z_{in} = Device input impedance as measured from gate to ground.

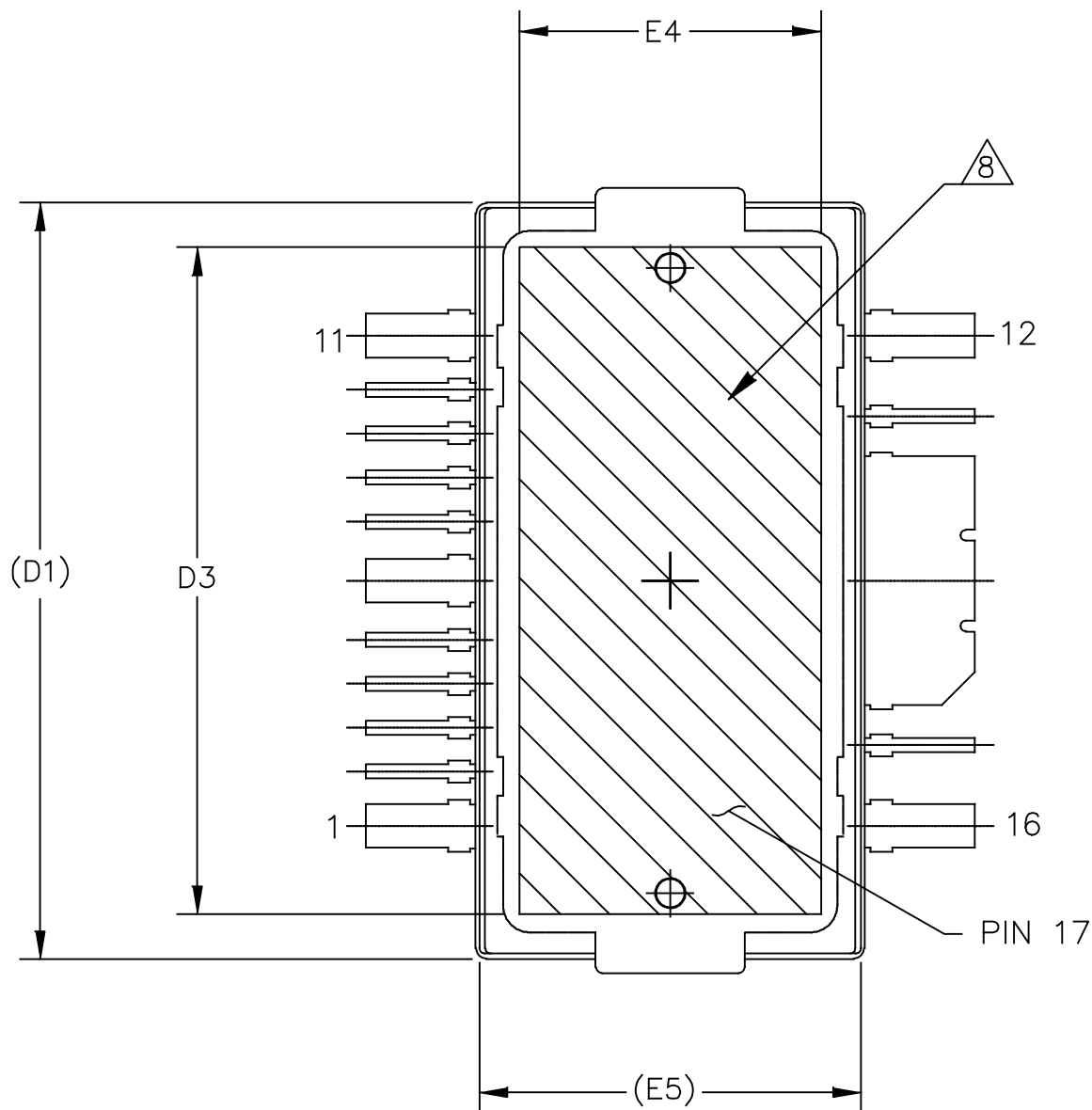
Z_{load} = Test circuit impedance as measured from drain to ground.



PACKAGE DIMENSIONS



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TITLE: TO-270 WIDE BODY 16 LEAD			DOCUMENT NO: 98ASA10754D		REV: A
			CASE NUMBER: 1886-01		31 AUG 2007
			STANDARD: NON-JEDEC		



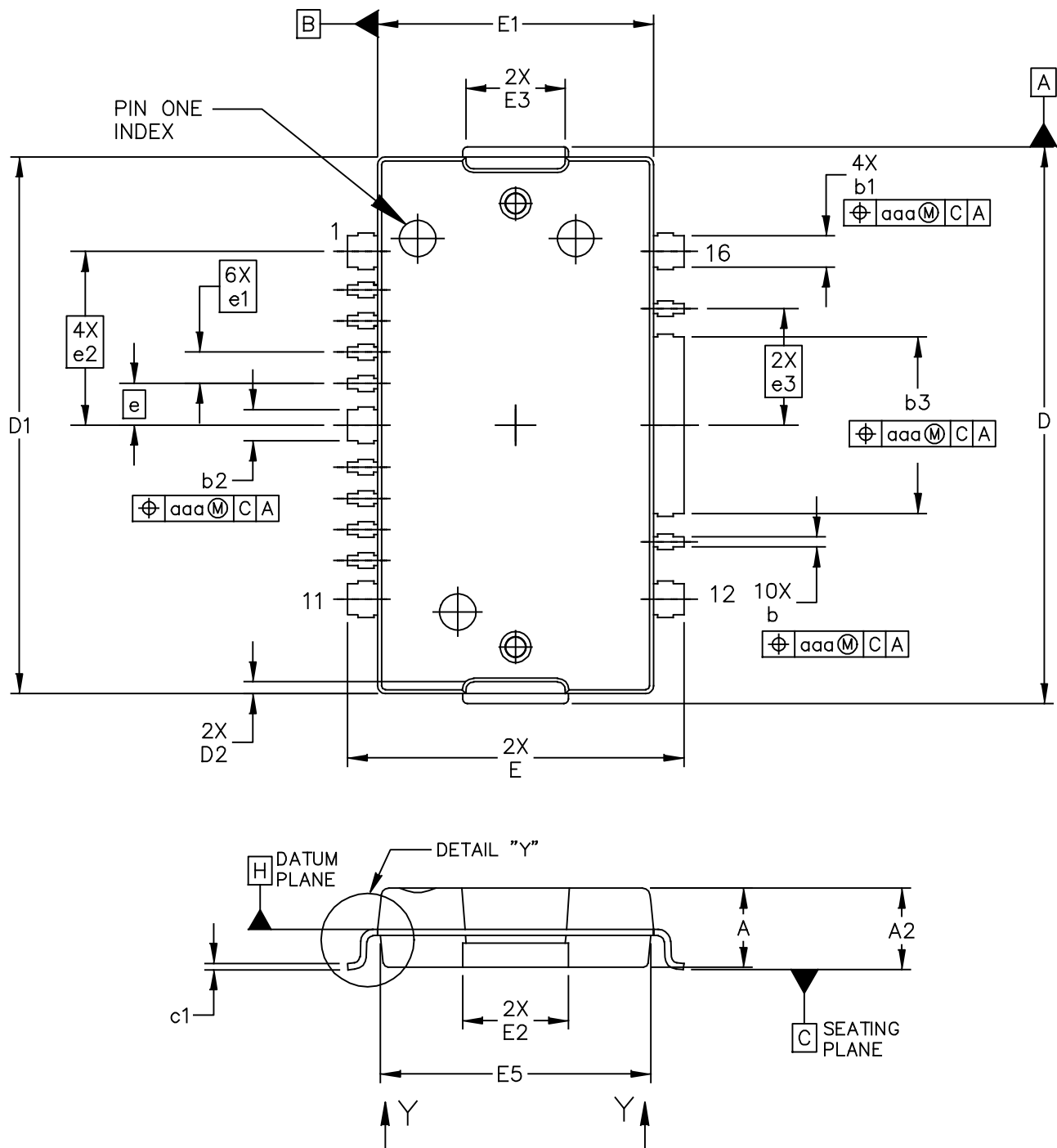
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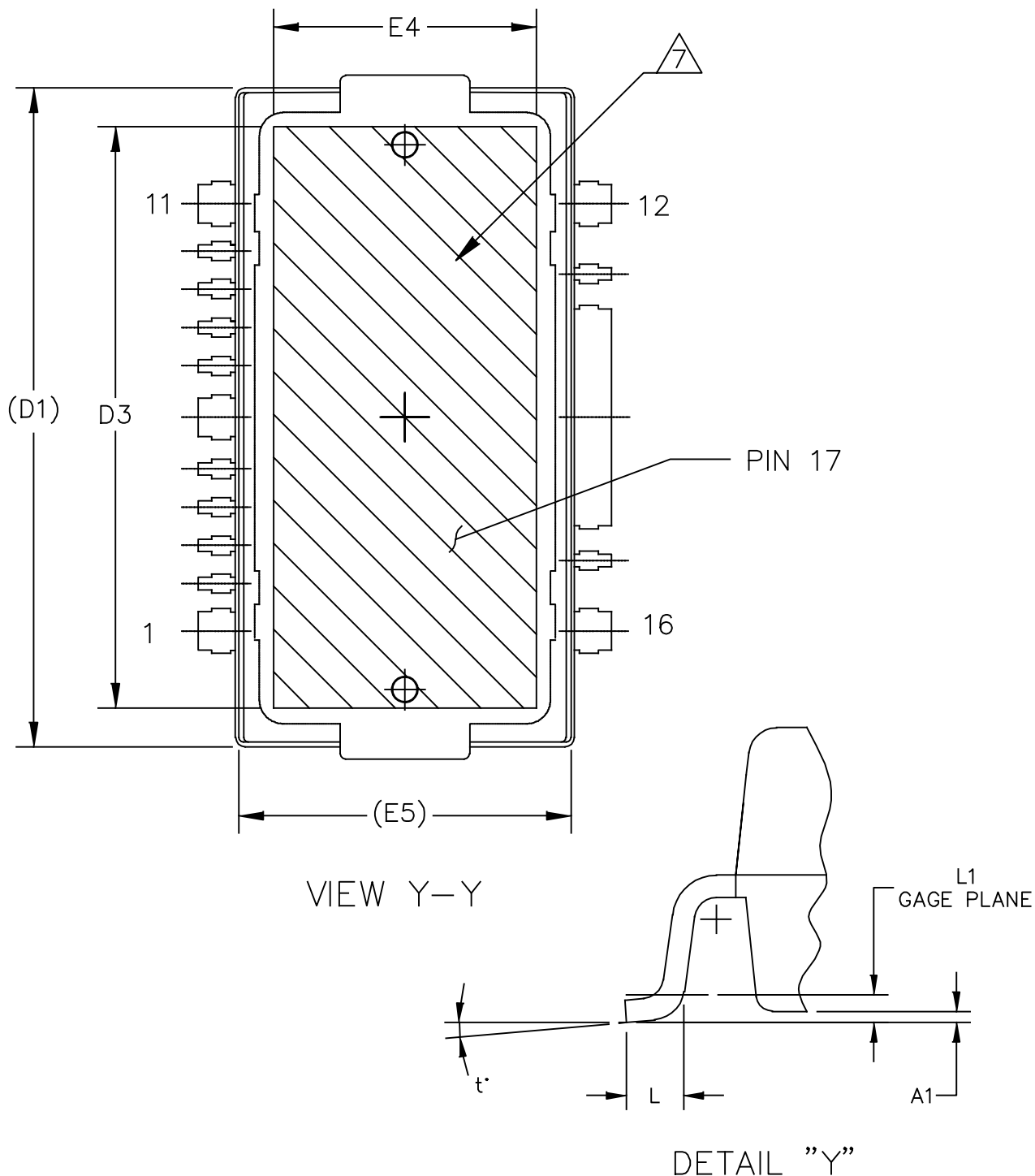
NOTES:

1. CONTROLLING DIMENSION: INCH
2. INTERPRET DIMENSIONS AND TOLERANCES PER ASME Y14.5M-1994.
3. DATUM PLANE -H- IS LOCATED AT THE TOP OF LEAD AND IS COINCIDENT WITH THE LEAD WHERE THE LEAD EXITS THE PLASTIC BODY AT THE TOP OF THE PARTING LINE.
4. DIMENSIONS "D" AND "E1" DO NOT INCLUDE MOLD PROTRUSION. ALLOWABLE PROTRUSION IS .006 (0.15) PER SIDE. DIMENSIONS "D" AND "E1" DO INCLUDE MOLD MISMATCH AND ARE DETERMINED AT DATUM PLANE -H-.
5. DIMENSIONS "b", "b1", "b2" AND "b3" DO NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE .005 (0.13) TOTAL IN EXCESS OF THE "b", "b1", "b2" AND "b3" DIMENSIONS AT MAXIMUM MATERIAL CONDITION.
6. DATUM -A- AND -B- TO BE DETERMINED AT DATUM PLANE -H-.
7. DIMENSION A2 APPLIES WITHIN ZONE "J" ONLY.
8. HATCHING REPRESENTS THE EXPOSED AREA OF THE HEAT SLUG. HATCHED AREA SHOWN IS ON THE SAME PLANE.

INCH			MILLIMETER		INCH			MILLIMETER	
DIM	MIN	MAX	MIN	MAX	DIM	MIN	MAX	MIN	MAX
A	.100	.104	2.54	2.64	F	.025 BSC		0.64 BSC	
A1	.039	.043	0.99	1.09	b	.011	.017	0.28	0.43
A2	.040	.042	1.02	1.07	b1	.037	.043	0.94	1.09
D	.712	.720	18.08	18.29	b2	.037	.043	0.94	1.09
D1	.688	.692	17.48	17.58	b3	.225	.231	5.72	5.87
D2	.011	.019	0.28	0.48	c1	.007	.011	.18	.28
D3	.600	---	15.24	---	e	.054 BSC		1.37 BSC	
E	.551	.559	14	14.2	e1	.040 BSC		1.02 BSC	
E1	.353	.357	8.97	9.07	e2	.224 BSC		5.69 BSC	
E2	.132	.140	3.35	3.56	e3	.150 BSC		3.81 BSC	
E3	.124	.132	3.15	3.35	aaa	.004		.10	
E4	.270	---	6.86	---					
E5	.346	.350	8.79	8.89					
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TITLE: TO-270 WIDE BODY 16 LEAD					DOCUMENT NO: 98ASA10754D			REV: A	
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1. CONTROLLING DIMENSION: INCH
2. INTERPRET DIMENSIONS AND TOLERANCES PER ASME Y14.5M-1994.
3. DATUM PLANE -H- IS LOCATED AT THE TOP OF LEAD AND IS COINCIDENT WITH THE LEAD WHERE THE LEAD EXITS THE PLASTIC BODY AT THE TOP OF THE PARTING LINE.
4. DIMENSIONS "D" AND "E1" DO NOT INCLUDE MOLD PROTRUSION.
ALLOWABLE PROTRUSION IS .006 (0.15) PER SIDE. DIMENSIONS "D" AND "E1" DO INCLUDE MOLD MISMATCH AND ARE DETERMINED AT DATUM PLANE -H-.
5. DIMENSIONS "b", "b1", "b2" AND "b3" DO NOT INCLUDE DAMBAR PROTRUSION.
ALLOWABLE DAMBAR PROTRUSION SHALL BE .005 (0.13) TOTAL IN EXCESS OF THE "b", "b1", "b2" AND "b3" DIMENSIONS AT MAXIMUM MATERIAL CONDITION.
6. DATUM -A- AND -B- TO BE DETERMINED AT DATUM PLANE -H-.
7. HATCHING REPRESENTS EXPOSED AREA OF THE HEAT SLUG. HATCHED AREA SHOWN IS ON THE SAME PLANE.

INCH			MILLIMETER		INCH			MILLIMETER	
DIM	MIN	MAX	MIN	MAX	DIM	MIN	MAX	MIN	MAX
A	.100	.104	2.54	2.64	L	.018	.024	0.46	0.61
A1	.001	.004	0.02	0.10	L1	.010 BSC		0.25 BSC	
A2	.099	.110	2.51	2.79	b	.011	.017	0.28	0.43
D	.712	.720	18.08	18.29	b1	.037	.043	0.94	1.09
D1	.688	.692	17.48	17.58	b2	.037	.043	0.94	1.09
D2	.011	.019	0.28	0.48	b3	.225	.231	5.72	5.87
D3	.600	---	15.24	---	c1	.007	.011	0.18	0.28
E	.429	.437	10.9	11.1	e	.054 BSC		1.37 BSC	
E1	.353	.357	8.97	9.07	e1	.040 BSC		1.02 BSC	
E2	.132	.140	3.35	3.56	e2	.224 BSC		5.69 BSC	
E3	.124	.132	3.15	3.35	e3	.150 BSC		3.81 BSC	
E4	.270	---	6.86	---	t	2'	8'	2'	8'
E5	.346	.350	8.79	8.89	aaa	.004		0.10	
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TITLE: TO-270 WIDE BODY 16 LEAD, GULL WING					DOCUMENT NO: 98ASA10755D				REV: A
					CASE NUMBER: 1887-01				31 AUG 2007
					STANDARD: NON-JEDEC				

PRODUCT DOCUMENTATION AND SOFTWARE

Refer to the following resources to aid your design process.

Application Notes

- AN1907: Solder Reflow Attach Method for High Power RF Devices in Plastic Packages
- AN1955: Thermal Measurement Methodology of RF Power Amplifiers
- AN1977: Quiescent Current Thermal Tracking Circuit in the RF Integrated Circuit Family
- AN1987: Quiescent Current Control for the RF Integrated Circuit Device Family
- AN3789: Clamping of High Power RF Transistors and RFICs in Over-Molded Plastic Packages

Engineering Bulletins

- EB212: Using Data Sheet Impedances for RF LDMOS Devices

Software

- Electromigration MTTF Calculator

To Download Resources Specific to a Given Part Number:

1. Go to <http://www.freescale.com/rf>
2. Search by part number
3. Click part number link
4. Choose the desired resource from the drop down menu

REVISION HISTORY

The following table summarizes revisions to this document.

Revision	Date	Description
0	Aug. 2015	• Initial Release of Data Sheet

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